

March 2015

# **FDS8672S**

# N-Channel PowerTrench<sup>®</sup> SyncFET<sup>TM</sup> 30V, 18A, 4.8m $\Omega$

#### **Features**

- Max  $r_{DS(on)} = 4.8m\Omega$  at  $V_{GS} = 10V$ ,  $I_D = 18A$
- Max  $r_{DS(on)} = 7.0 \text{m}\Omega$  at  $V_{GS} = 4.5 \text{V}$ ,  $I_D = 15 \text{A}$
- Includes SyncFET Schottky Body Diode
- High Performance Trench Technology for Extremely Low r<sub>DS(on)</sub> and Fast Switching
- High Power and Current Handling Capability
- 100% R<sub>a</sub> (Gate Resistance) Tested
- Termination is Lead-free and RoHS Compliant

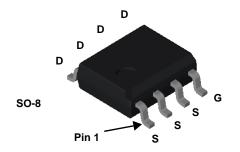


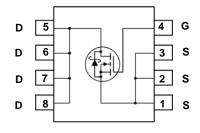
#### **General Description**

The FDS8672S is designed to replace a single MOSFET and Schottky diode in synchronous DC/DC power supplies. This 30V MOSFET is designed to maximize power conversion efficiency, providing a low  $r_{\rm DS(on)}$  and low gate charge. The FDS8672S includes a patented combination of a MOSFET monolithically integrated with a Schottky diode using Fairchild's monolithic SyncFET technology.

#### **Applications**

- Synchronous Rectifier for DC/DC Converters
- Notebook Vcore Low Side Switch
- Point of Load Low Side Switch





#### **MOSFET Maximum Ratings** $T_A = 25$ °C unless otherwise noted.

Symbol	Parameter			Ratings	Units
$V_{DS}$	Drain to Source Voltage			30	V
$V_{GS}$	Gate to Source Voltage			±20	V
I <sub>D</sub>	Drain Current -Continuous			18	^
	-Pulsed		(Note 4)	80	Α
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	216	mJ
D	Power Dissipation	$T_A = 25$ °C	(Note 1a)	2.5	W
$P_{D}$	Power Dissipation	$T_A = 25$ °C	(Note 1b)	1.0	VV
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Tempe	erature Range		-55 to +150	°C

#### **Thermal Characteristics**

I	$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Note 1)	25	°C/W
I	$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	50	*C/VV

#### **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDS8672S	FDS8672S	SO8	13"	12mm	2500 units

# **Electrical Characteristics** $T_J = 25$ °C unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Chara	acteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 1mA$ , $V_{GS} = 0V$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 10mA, referenced to 25°C		33		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V			500	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA

#### On Characteristics

V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 1mA$	1.0	2.1	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 10mA, referenced to 25°C		-5		mV/°C
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 18A		3.8	4.8	
		$V_{GS} = 4.5V, I_D = 15A$		5.3	7.0	mΩ
		$V_{GS} = 10V, I_D = 18A, T_J = 125^{\circ}C$		5.3	7.8	
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5V, I_{D} = 18A$		78		S

#### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 45V V 0V		2005	2670	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 15V, V_{GS} = 0V,$ f = 1MHz		985	1310	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			135	205	pF
$R_g$	Gate Resistance	f = 1MHz		0.6	2.0	Ω

## **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time			12	22	ns
t <sub>r</sub>	Rise Time	$V_{DD} = 15V, I_{D} = 18A,$ $V_{GS} = 10V, R_{GEN} = 6\Omega$		4	10	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10V, R_{GEN} = 002$		26	42	ns
t <sub>f</sub>	Fall Time			3	10	ns
$Q_g$	Total Gate Charge	V <sub>GS</sub> = 0V to 10V		29	41	nC
Qg	Total Gate Charge	$V_{GS} = 0V \text{ to } 5V$ $V_{DD} = 15$ $I_{D} = 18A$	V,	15	21	nC
Q <sub>gs</sub>	Gate to Source Charge	I <sub>D</sub> = 18A	,	5.5		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge			3.7		nC

### **Drain-Source Diode Characteristics**

V <sub>SD</sub> Source to Drain Diode	Source to Drain Diado, Forward Voltage	V <sub>GS</sub> = 0V, I <sub>S</sub> = 18A	0.8	1.2	V
	Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_S = 1.8A$	0.4	0.7	V
t <sub>rr</sub>	Reverse Recovery Time	- I <sub>E</sub> = 18A, di/dt = 300A/μs	27	43	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$-1$ F = 16A, $\frac{1}{4}$ $\frac$	31	50	nC
NOTES:					

<sup>1.</sup> R<sub>0JA</sub> is determined with the device mounted on a 1in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



a) 50°C/W when mounted on a 1in<sup>2</sup> pad of 2 oz copper.



b) 125°C/W when mounted on a minimum pad.

<sup>2.</sup> Pulse Test: Pulse Width <  $300\mu$ s, Duty cycle < 2.0%. 3. Starting T<sub>J</sub> =  $25^{\circ}$ C, L = 3mH, I<sub>AS</sub> = 12A, V<sub>DD</sub> = 30V, V<sub>GS</sub> = 10V. 4. Pulse current was measured at 250uS pulse, refer to Fig 11 Forward Safe Operation Area for detail.

### **Typical Characteristics** T<sub>J</sub> = 25°C unless otherwise noted.

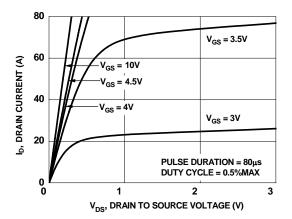


Figure 1. On-Region Characteristics

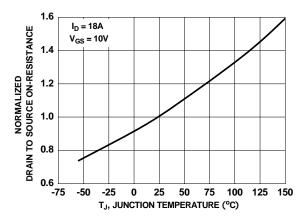


Figure 3. Normalized On-Resistance vs. Junction Temperature

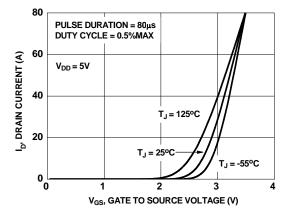


Figure 5. Transfer Characteristics

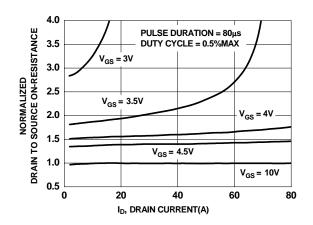


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

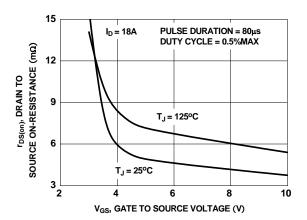


Figure 4. On-Resistance vs. Gate to Source Voltage

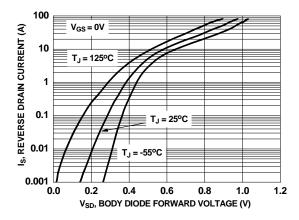


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

# Typical Characteristics $T_J = 25$ °C unless otherwise noted.

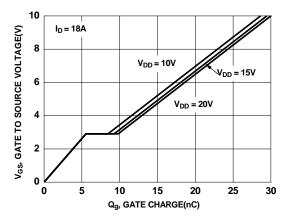


Figure 7. Gate Charge Characteristics

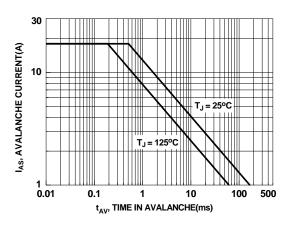


Figure 9. Unclamped Inductive Switching Capability

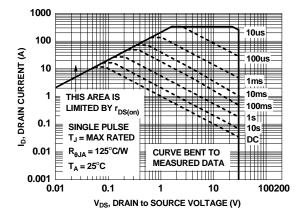


Figure 11. Forward Bias Safe Operating Area

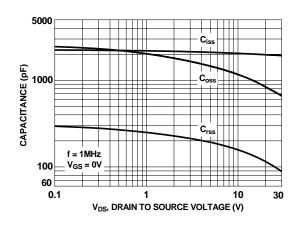


Figure 8. Capacitance vs. Drain to Source Voltage

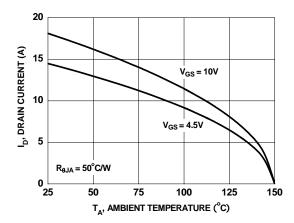


Figure 10. Maximum Continuous Drain Current vs. Ambient Temperature

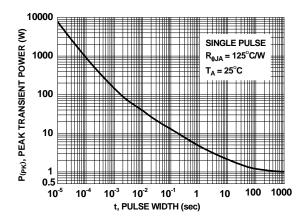


Figure 12. Single Pulse Maximum Power Dissipation

# **Typical Characteristics** T<sub>J</sub> = 25°C unless otherwise noted.

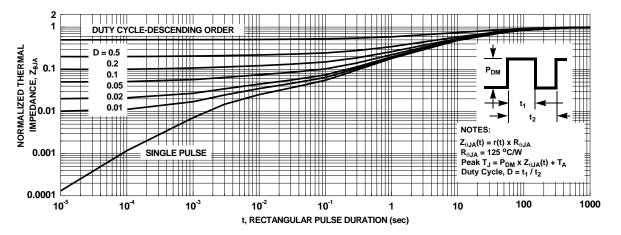
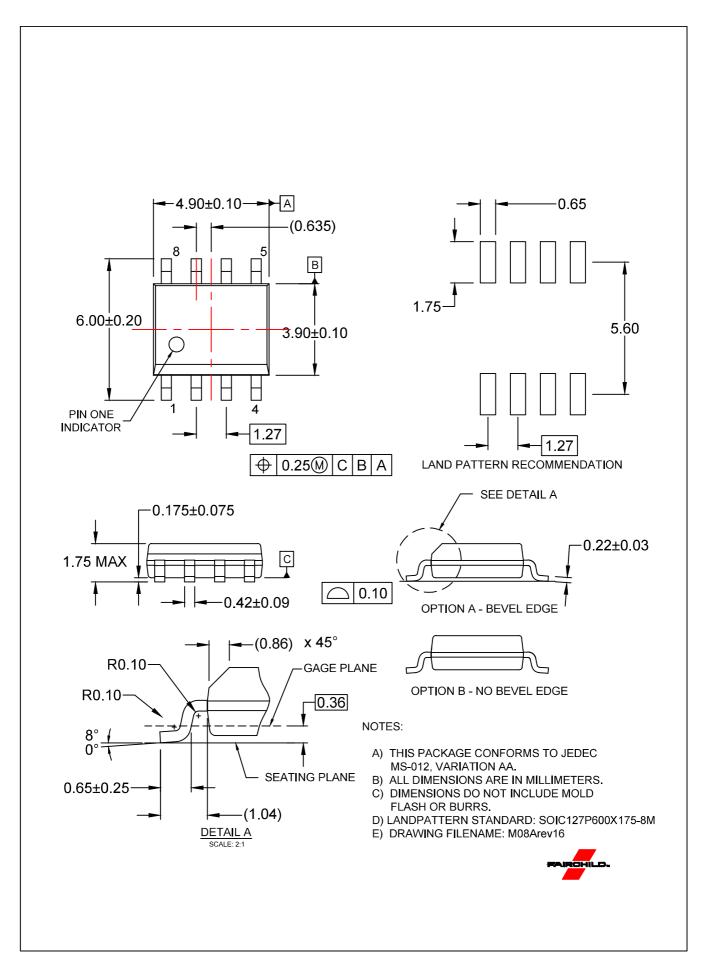


Figure 13. Junction-to-Ambient Transient Thermal Response Curve







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